

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/676,598	OPEROWSKY ET AL.	
Examiner	Art Unit	
John A. Tweel, Jr.	2636	

SEARCHED				
Class	Subclass	Date	Examiner	
340	425.5	12/22/2005	JAT	
	988			
	980			
	990			
	995.1			
	995.2			
345	7	12/22/2005	JAT	
701	201			
	208			
	213	12/22/2005	JAT	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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